Search Notes



Application/Control No.

Reexamination 10565162 CHANG ET AL.

Examiner

Art Unit

Applicant(s)/Patent Under

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2886

SEARCHED

Class	Subclass	Date	Examiner
356	432-444, 244, 246, 39, 72-73	4/6/08	SN
250	559.01, 559.09, 206.1	4/6/08	SN
422	82.05, 61-63, 67	4/6/08	SN
436	517, 528	4/6/08	SN

SEARCH NOTES

Search Notes	Date	Examiner		
EAST searched history printout	4/6/08	SN		
PGPUB database interference search	4/6/08	SN		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
356	432, 246	4/6/08	SN

U.S. Patent and Trademark Office Part of Paper No.: 20080406